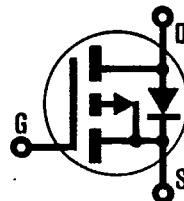


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**HEXFET® TRANSISTORS IRF9540****P-CHANNEL
100 VOLT
POWER MOSFETs****IRF9541****IRF9542****IRF9543****-100 Volt, 0.2 Ohm HEXFET
TO-220AB Plastic Package**

The HEXFET technology is the key to International Rectifier's advanced line of power MOSFET transistors. The efficient geometry and unique processing of the HEXFET design achieve very low on-state resistance combined with high transconductance and extreme device ruggedness.

The P-Channel HEXFETs are designed for applications which require the convenience of reverse polarity operation. They retain all of the features of the more common N-Channel HEXFETs such as voltage control, very fast switching, ease of paralleling, and excellent temperature stability. The P-Channel IRF9540 device is an approximate electrical complement to the N-Channel IRF530 HEXFET.

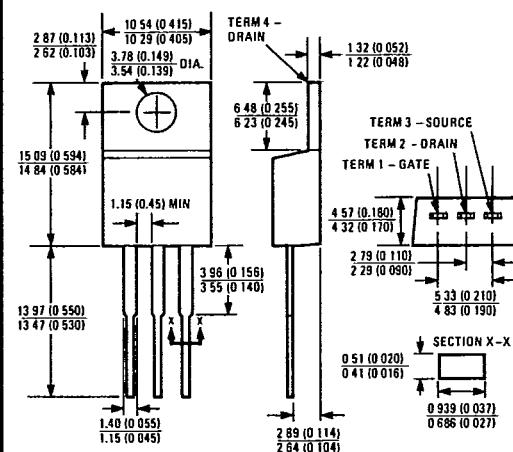
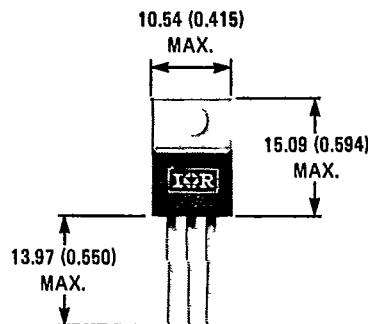
P-Channel HEXFETs are intended for use in power stages where complementary symmetry with N-Channel devices offers circuit simplification. They are also very useful in drive stages because of the circuit versatility offered by the reverse polarity connection. Applications include motor control, audio amplifiers, switched mode converters, control circuits and pulse amplifiers.

Product Summary

Part Number	V _{DS}	R _{DS(on)}	I _D
IRF9540	-100V	0.2Ω	-19A
IRF9541	-60V	0.25Ω	-19A
IRF9542	-100V	0.3Ω	-15A
IRF9543	-60V	0.3Ω	-15A

**Features:**

- P-Channel Versatility
- Compact Plastic Package
- Fast Switching
- Low Drive Current
- Ease of Paralleling
- Excellent Temperature Stability

CASE STYLE AND DIMENSIONS

Case Style TO-220AB
Dimensions In Millimeters and (Inches)

IRF9540, IRF9541, IRF9542, IRF9543 Devices

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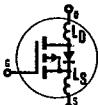
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Absolute Maximum Ratings

Parameter	IRF9540	IRF9541	IRF9542	IRF9543	Units
V _{DS} Drain - Source Voltage ①	-100	-60	-100	-60	V
V _{DGR} Drain - Gate Voltage ($R_{GS} = 20\text{ k}\Omega$) ①	-100	-60	-100	-60	V
I _D @ $T_C = 25^\circ\text{C}$ Continuous Drain Current	-19	-19	-15	-15	A
I _D @ $T_C = 100^\circ\text{C}$ Continuous Drain Current	-12	-12	-10	-10	A
I _{DM} Pulsed Drain Current ③	-76	-76	-60	-60	A
V _{GS} Gate - Source Voltage		±20			V
P _D @ $T_C = 25^\circ\text{C}$ Max. Power Dissipation	125	(See Fig. 14)			W
Linear Derating Factor	1.0	(See Fig. 14)			W/K④
I _{LM} Inductive Current, Clamped	-76	-76	-60	-60	A
T _J Operating Junction and Storage Temperature Range		-55 to 150			°C
T _{Stg}					
Lead Temperature	300 (0.063 in. (1.6mm) from case for 10s)				°C

Electrical Characteristics @ $T_C = 25^\circ\text{C}$ (Unless Otherwise Specified)

Parameter	Type	Min.	Typ.	Max.	Units	Test Conditions
BV _{DSS} Drain - Source Breakdown Voltage	IRF9540	-100	—	—	V	$V_{GS} = 0\text{V}$ $I_D = -250\mu\text{A}$
	IRF9542	-60	—	—	V	
V _{GS(th)} Gate Threshold Voltage	ALL	-2.0	—	-4.0	V	$V_{DS} = V_{GS}, I_D = -250\mu\text{A}$ $V_{GS} = -20\text{V}$
	IRF9541 IRF9543	—	—	-500	nA	
I _{GSS} Gate - Source Leakage Forward	ALL	—	—	500	nA	$V_{GS} = 20\text{V}$
	IRF9542 IRF9543	—	—	-250	μA	
I _{GSS} Gate - Source Leakage Reverse	ALL	—	—	-1000	μA	$V_{DS} = \text{Max. Rating}, V_{GS} = 0\text{V}$ $V_{DS} = \text{Max. Rating} \times 0.8, V_{GS} = 0\text{V}, T_C = 125^\circ\text{C}$
	IRF9540 IRF9541	-19	—	—	A	
I _{D(on)} On-State Drain Current ②	IRF9542 IRF9543	-15	—	—	A	$V_{DS} > I_{D(on)} \times R_{DS(on)\text{max.}}, V_{GS} = -10\text{V}$
	IRF9540 IRF9541	—	0.15	0.2	Ω	
R _{DS(on)} Static Drain-Source On-State Resistance ②	IRF9542 IRF9543	—	0.22	0.3	Ω	$V_{GS} = -10\text{V}, I_D = -10\text{A}$
	IRF9540 IRF9541	—	—	—	S (Ω)	
g _{fs} Forward Transconductance ②	ALL	5.0	7.0	—	S (Ω)	$V_{DS} > I_{D(on)} \times R_{DS(on)\text{max.}}, I_D = -6.0\text{A}$
	ALL	—	1100	1300	pF	
C _{iss} Input Capacitance	ALL	—	550	700	pF	$V_{GS} = 0\text{V}, V_{DS} = -25\text{V}, f = 1.0\text{ MHz}$ See Fig. 10
C _{oss} Output Capacitance	ALL	—	250	400	pF	
C _{rss} Reverse Transfer Capacitance	ALL	—	20	30	ns	$V_{DD} = 0.5 \times V_{DSS}, I_D = -10\text{A}, Z_0 = 4.7\Omega$ See Fig. 17
t _{d(on)} Turn-On Delay Time	ALL	—	10	15	ns	
t _r Rise Time	ALL	—	13	20	ns	(MOSFET switching times are essentially independent of operating temperature.)
t _{d(off)} Turn-Off Delay Time	ALL	—	8.0	12	ns	
t _f Fall Time	ALL	—	—	—	—	$V_{GS} = -15\text{V}, I_D = -24\text{A}, V_{DS} = 0.8 \text{ Max. Rating.}$ See Fig. 18 for test circuit. (Gate charge is essentially independent of operating temperature.)
Q _g Total Gate Charge (Gate-Source Plus Gate-Drain)	ALL	—	70	90	nC	
Q _{gs} Gate-Source Charge	ALL	—	14	—	nC	Measured from the contact screw on tab to center of die.
Q _{gd} Gate-Drain ("Miller") Charge	ALL	—	56	—	nC	
L _D Internal Drain Inductance	ALL	—	3.5	—	nH	Modified MOSFET symbol showing the internal device inductances.
	ALL	—	4.5	—	nH	
L _S Internal Source Inductance	ALL	—	7.5	—	nH	Measured from the source lead, 6mm (0.25 in.) from package to source bonding pad.



Thermal Resistance

R _{thJC} Junction-to-Case	ALL	—	—	1.0	K/W④	
R _{thCS} Case-to-Sink	ALL	—	1.0	—	K/W④	Mounting surface flat, smooth, and greased.
R _{thJA} Junction-to-Ambient	ALL	—	—	80	K/W④	Typical socket mount

IRF9540, IRF9541, IRF9542, IRF9543 Devices

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Source-Drain Diode Ratings and Characteristics

I_S	Continuous Source Current (Body Diode)	IRF9540 IRF9541	—	—	-19	A	Modified MOSFET symbol showing the integral reverse P-N junction rectifier.
		IRF9542 IRF9543	—	—	-15	A	
I_{SM}	Pulse Source Current (Body Diode) ①	IRF9540 IRF9541	—	—	-76	A	T-39-23
		IRF9542 IRF9543	—	—	-60	A	
V_{SD}	Diode Forward Voltage ②	IRF9540 IRF9541	—	—	-4.2	V	$T_C = 25^\circ\text{C}, I_S = -19\text{A}, V_{GS} = 0\text{V}$
		IRF9542 IRF9543	—	—	-4.0	V	$T_C = 25^\circ\text{C}, I_S = -15\text{A}, V_{GS} = 0\text{V}$
t_{rr}	Reverse Recovery Time	ALL	—	170	—	ns	$T_J = 150^\circ\text{C}, I_F = -19\text{A}, dI/dt = 100\text{A}/\mu\text{s}$
Q_{RR}	Reverse Recovered Charge	ALL	—	0.8	—	μC	$T_J = 150^\circ\text{C}, I_F = -19\text{A}, dI/dt = 100\text{A}/\mu\text{s}$
t_{on}	Forward Turn-on Time	ALL	Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by $L_S + L_D$.				

① $T_J = 25^\circ\text{C}$ to 150°C . ② Pulse Test: Pulse width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$.

③ Repetitive Rating: Pulse width limited by max. junction temperature.

See Transient Thermal Impedance Curve (Fig. 5).

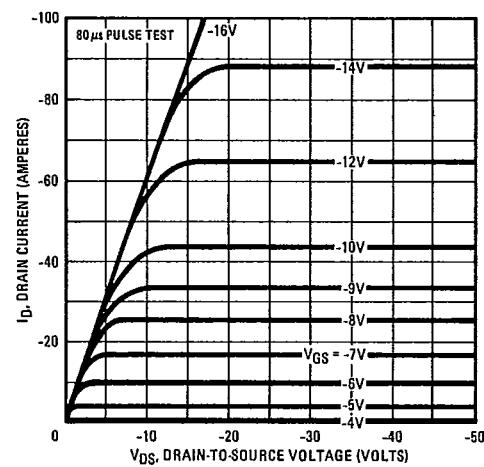


Fig. 1 – Typical Output Characteristics

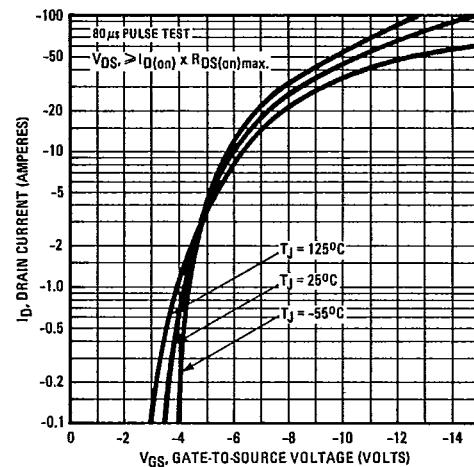


Fig. 2 – Typical Transfer Characteristics

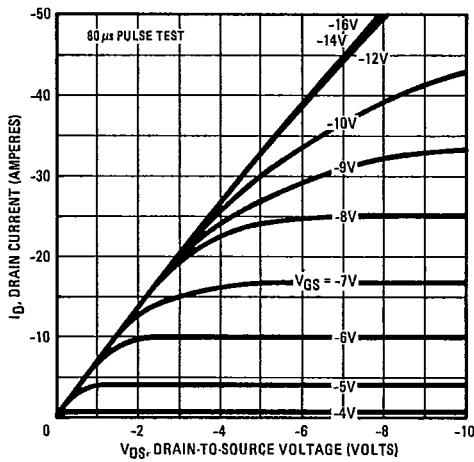


Fig. 3 – Typical Saturation Characteristics

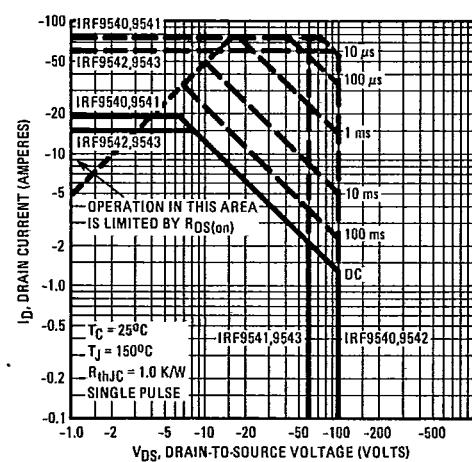


Fig. 4 – Maximum Safe Operating Area

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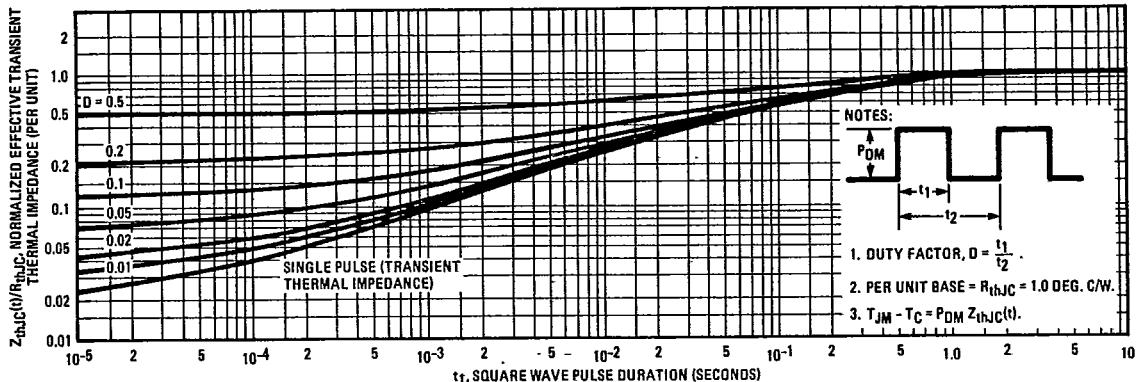


Fig. 5 – Maximum Effective Transient Thermal Impedance, Junction-to-Case Vs. Pulse Duration

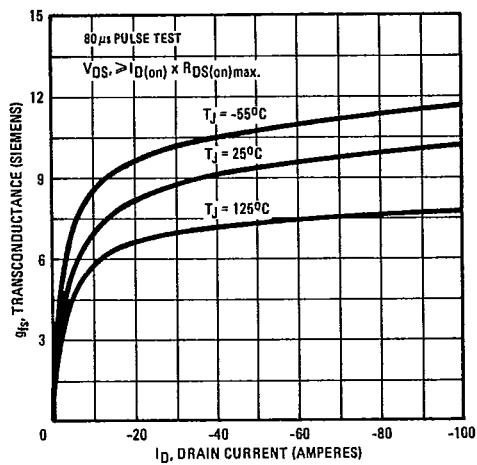


Fig. 6 – Typical Transconductance Vs. Drain Current

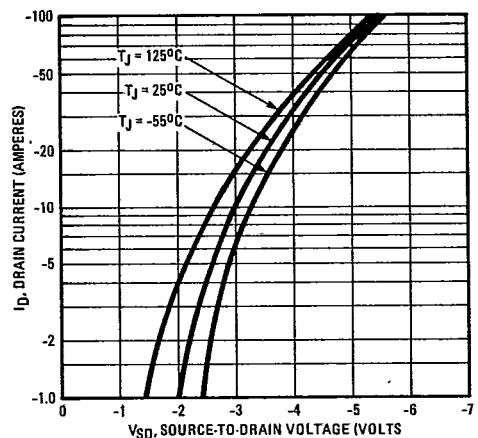


Fig. 7 – Typical Source-Drain Diode Forward Voltage

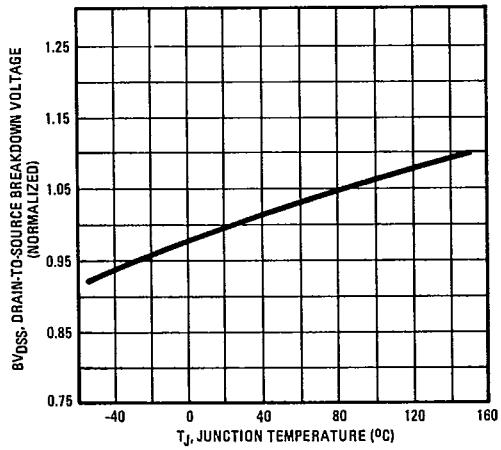


Fig. 8 – Breakdown Voltage Vs. Temperature

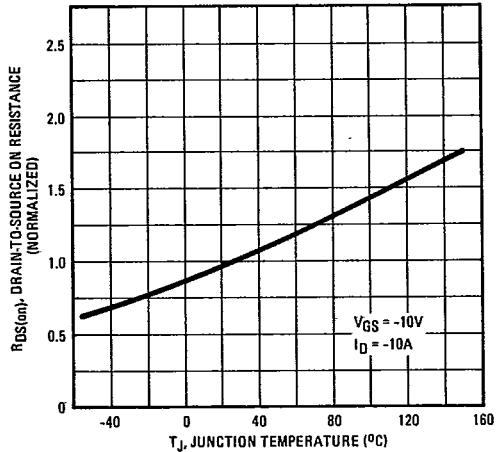


Fig. 9 – Normalized On-Resistance Vs. Temperature

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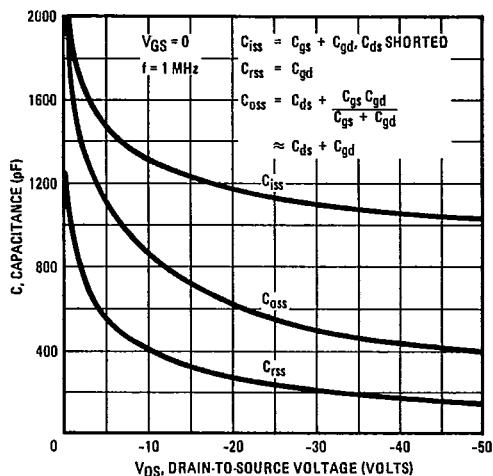


Fig. 10 — Typical Capacitance Vs. Drain-to-Source Voltage

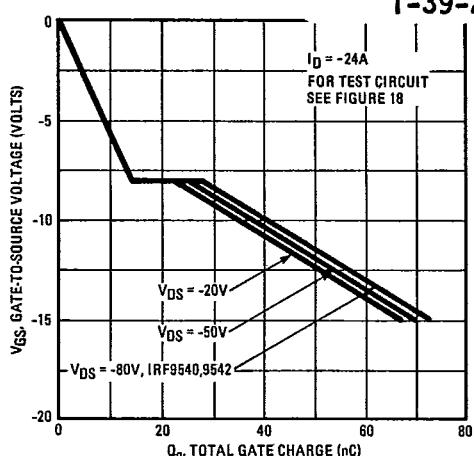


Fig. 11 — Typical Gate Charge Vs. Gate-to-Source Voltage

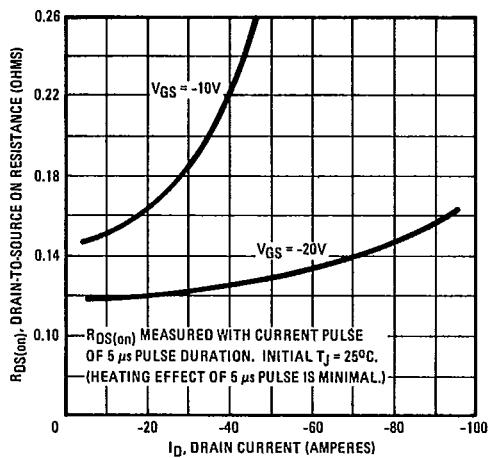


Fig. 12 — Typical On-Resistance Vs. Drain Current

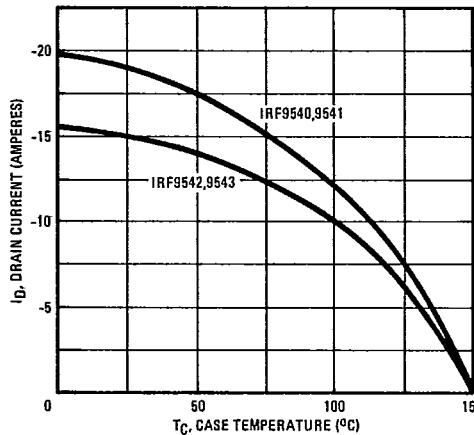


Fig. 13 — Maximum Drain Current Vs. Case Temperature

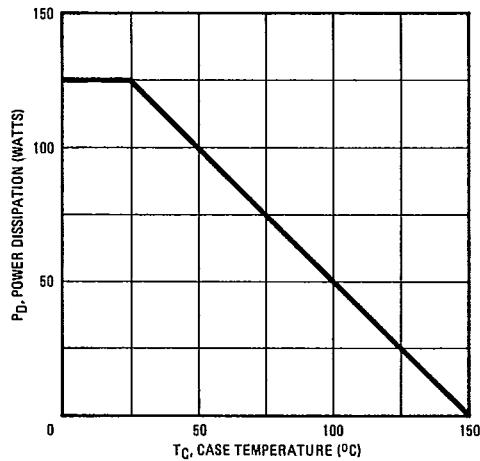


Fig. 14 — Power Vs. Temperature Derating Curve

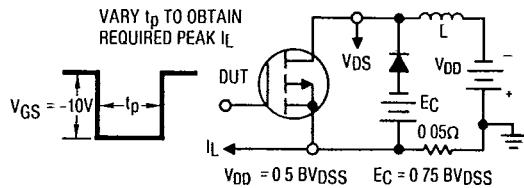


Fig. 15 — Clamped Inductive Test Circuit

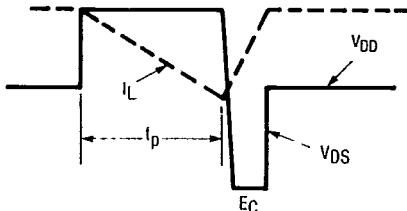


Fig. 16 — Clamped Inductive Waveforms

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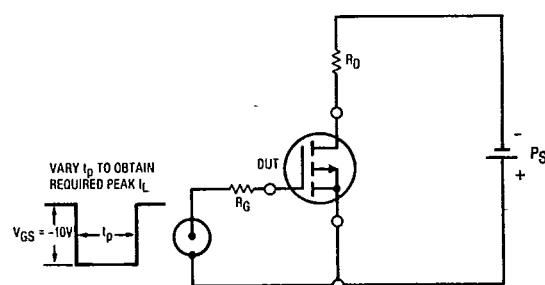


Fig. 17 — Switching Time Test Circuit

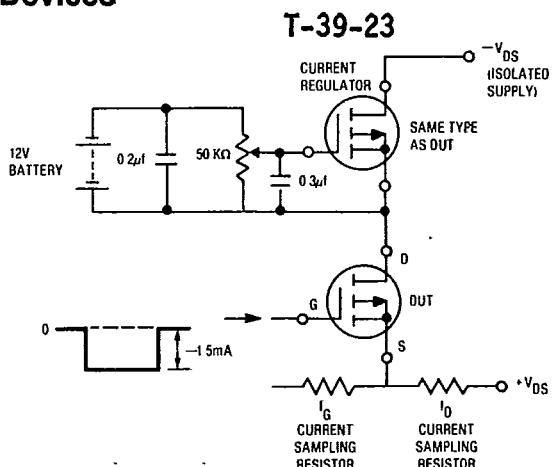
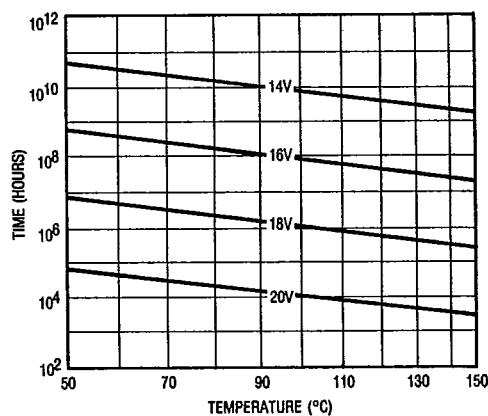
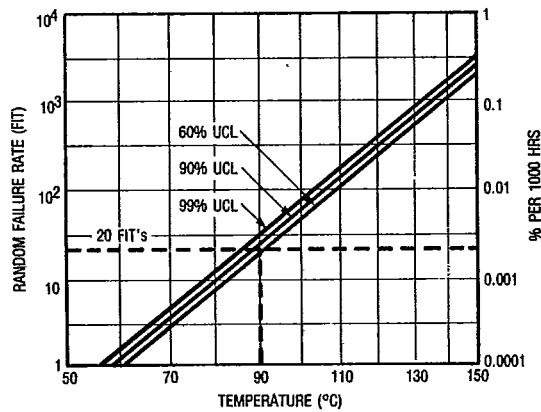


Fig. 18 — Gate Charge Test Circuit



*Fig. 19 — Typical Time to Accumulated 1% Gate Failure

*The data shown is correct as of April 15, 1987. This information is updated on a quarterly basis; for the latest reliability data, please contact your local IR field office.



*Fig. 20 — Typical High Temperature Reverse Bias (HTRB) Failure Rate